

SG - 2BC

The SG - 2BC reflective sensor combines a GaAs IRED with a high - sensitivity phototransistor in a super - mini (4 ϕ ceramic package, reducing installation space.

FEATURES

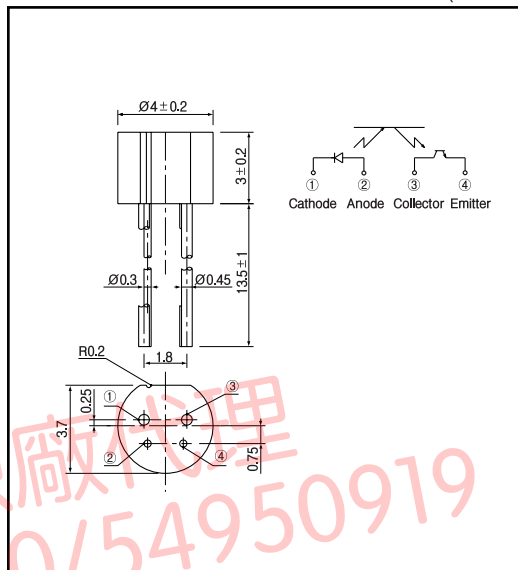
- Compact ($\phi 4$ mm)
- High performance
- High - speed response
- Easy to mount on P.C.B.
- Widely applicable

APPLICATIONS

- Timing sensors
- Edge sensors
- Micro floppy disk drives
- Level sensors of liquid

DIMENSIONS

(Unit : mm)



MAXIMUM RATINGS

(Ta=25 °C)

Item	Symbol	Rating	Unit
Input	Power dissipation	P_D	75
	Reverse voltage	V_R	5
	Forward current	I_F	50
	Pulse forward current *1	I_{FP}	1
Output	Collector power dissipation	P_C	75
	Collector current	I_C	20
	C - E voltage	V_{CE0}	30
	E - C voltage	V_{ECO}	3
	Operating temp.	$T_{opr.}$	- 20 + 90
	Storage temp.	$T_{stg.}$	- 30 + 100
	Soldering temp.	$T_{sol.}$	260

*1. t w 100 μ sec. period : T=10msec.

*2. For MAX. 5 seconds at the position of 2mm from the package

ELECTRO-OPTICAL CHARACTERISTICS

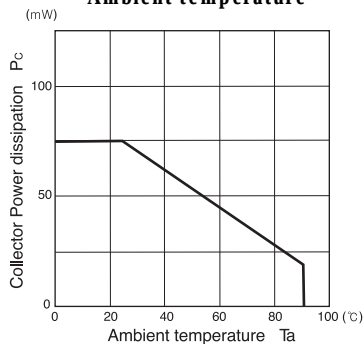
(Ta=25 °C)

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit.
Input	Forward voltage	V_F	$I_F = 4$ mA		1.2	V
	Reverse current	I_R	$V_R = 5$ V		10	μ A
	Capacitance	C_t	$V = 0$ V, $f = 1$ KHz	25		pF
	Peak wavelength	λ_p		940		nm
Output	Collector dark current	I_{CEO}	$V_{CE} = 10$ V		0.1	μ A
	Ligh current	I_L	$V_{CE} = 2$ V, $I_F = 4$ mA	100		μ A
	Leakage current	I_{CEO0}	$V_{CE} = 2$ V, $I_F = 4$ mA		0.1	μ A
Switching speeds	Rise time	t_r	$V_{CC} = 2$ V, $I_F = 100$ μ A, $R = 1$ k Ω	30		μ sec.
	Fall time	t_f		30		μ sec.

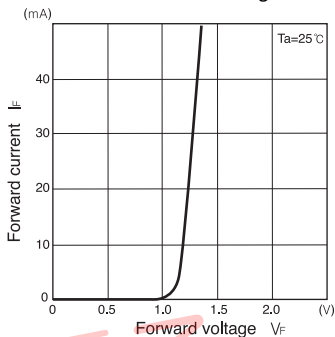
Photo interrupters(Reflective)

SG - 2BC

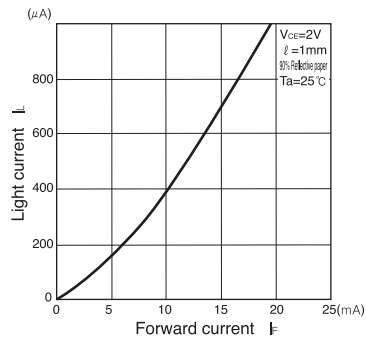
Collector power dissipation Vs. Ambient temperature



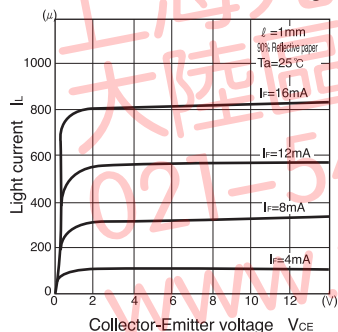
Forward current Vs. Forward voltage



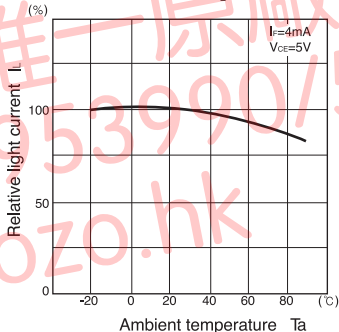
Light current Vs. Forward current



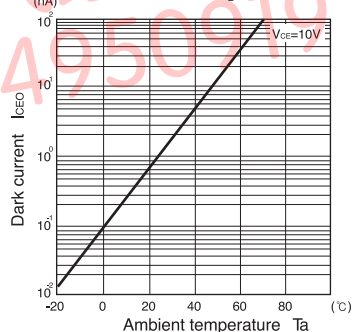
Light current Vs. Collector-Emitter voltage



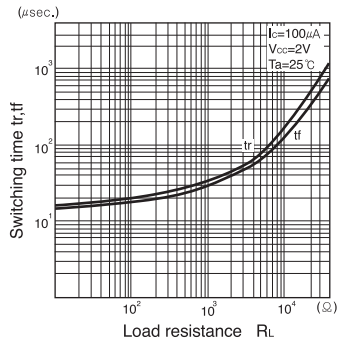
Relative light current Vs. Ambient temperature



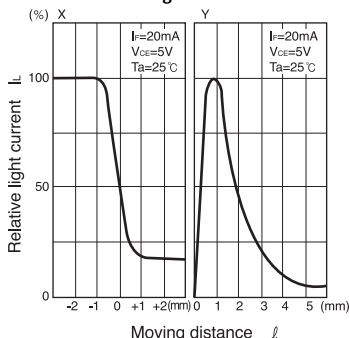
Dark current Vs. Ambient temperature



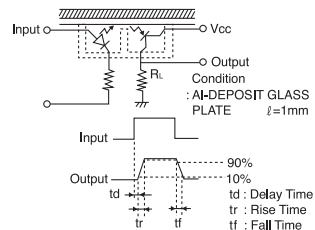
Switching time Vs. Load resistance



Relative light current Vs. Moving distance



Switching time measurement circuit



Method of measuring position characteristic

